## **AMENDMENTS TO THE CLAIMS**

(Currently Amended) A method for inspecting a display device 1. substrate having a plurality of signal wirings and a plurality of electrostatic discharge damage (ESD) protection devices, the method comprising steps of:

shorting short-circuiting the ESD protection devices to form a current path on each of the signal wirings;

supplying a current to the signal wirings; and

determining a defectiveness of at least one of the signal wirings depending on the current flowing on the signal wirings.

- 2. (Currently Amended) The method according to claim 1, wherein in-the shorting short-circuiting step comprises short-circuiting, the ESD protection devices are shorted with by a conductive shorting bar.
- 3. (Original) The method according to claim 1, wherein the step of supplying the current to the signal wirings includes:

supplying a high voltage through a first shorting wiring connected to the signal wirings; and

supplying a low voltage through a second shorting wiring connected to the ESD protection devices.

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4. (Currently Amended) The method according to claim 1, wherein in the

shoring short-circuiting step, the display device substrate is a TFT array

substrate of a liquid crystal display.

5. (Withdrawn) A method for inspecting a display device substrate having

a plurality of signal wirings and a plurality of electrostatic discharge damage

(ESD) protection devices, the method comprising steps of:

supplying a voltage to a control terminal of each of the ESD protection

devices to turn on the ESD protection devices and thereby form a current path

on each of the signal wirings;

supplying a current to the signal wirings; and

determining a defectiveness of at least one of the signal wirings

depending on the current flowing on the signal wirings.

6. (Withdrawn) The method according to claim 5, wherein in the voltage

supplying step, the voltage is supplied through a dummy shorting wiring

connected to the control terminal of each of the ESD protection devices.

7. (Withdrawn) The method according to claim 6, wherein the control

terminal of each of the ESD protection devices includes a gate terminal of a

transistor.

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8. (Withdrawn) The method according to claim 5, wherein in the voltage

supplying step, the voltage is supplied through a shorting wiring connected to

the control terminal of each of the ESD protection devices and to input/output

terminals of the ESD protection devices.

9. (Withdrawn) The method according to claim 8, wherein in the voltage

supplying step, the control terminal of each of the ESD protection devices

includes a gate terminal of a transistor, and the input/output terminal of each

of the ESD protection devices includes a source/drain terminal of the

corresponding transistor.

10. (Withdrawn) The method according to claim 5, wherein in the voltage

applying step, the display device substrate is a TFT array substrate of a liquid

crystal display.

11. (Currently Amended) An apparatus for inspecting a display device

substrate having a plurality of signal wirings and a plurality of electrostatic

discharge damage (ESD) protection devices, the apparatus comprising:

a conductive shorting bar to short-short-circuit the ESD protection

devices;

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a power supply to supply a current to the signal wirings; and

a detection circuit to determine a defectiveness of at least one of the signal wirings depending on the current flowing on the signal wirings.

12. (Original) The apparatus according to claim 11, wherein the conductive shorting bar is provided in a jig.

13. (Original) The apparatus according to claim 11, further comprising:

a first shorting wiring connected to the signal wirings; and

a second shorting wiring connected to the ESD protection devices,

wherein the power supply supplies a high voltage to the signal wirings through the first shorting wiring, and a low voltage to the ESD protection devices through the second shorting wiring.

- 14. (Original) The apparatus according to claim 11, wherein the display device substrate is a TFT array substrate of a liquid crystal display.
- 15. (Withdrawn) An apparatus for inspecting a display device substrate having a plurality of signal wirings and a plurality of electrostatic discharge damage (ESD) protection devices, the apparatus comprising:

a control circuit to supply a voltage to a control terminal of each of the

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ESD protection devices to turn on the ESD protection devices, so as to form a

current path on each of the signal wirings;

a power supply to supply a current to the signal wirings; and

a detection circuit to determine a defectiveness of at least one of the

signal wirings depending on the current flowing on the signal wirings.

16. (Withdrawn) The apparatus according to claim 15, further

comprising:

a dummy shorting wiring through which the control circuit supplies the

voltage to the control terminal of each of the ESD protection devices.

17. (Withdrawn) The apparatus according to claim 16, wherein the

dummy shorting wiring is formed on the display device substrate.

18. (Withdrawn) The apparatus according to claim 15, wherein the

control terminal of each of the ESD protection devices includes a gate terminal

of a transistor.

19. (Withdrawn) The apparatus according to claim 15, further

comprising:

a shorting wiring connected to the control terminal of each of the ESD

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protection devices and to an input/output terminal of each of the ESD

protection devices,

wherein the control circuit supplies the voltage to the control terminals of

the ESD protection devices through the shorting wiring.

20. (Withdrawn) The apparatus according to claim 19, wherein the

shorting wiring is formed on the display device substrate.

21. (Withdrawn) The apparatus according to claim 19, wherein the

control terminal of each of the ESD protection devices includes a gate terminal

of a transistor, and the input/output terminal of each of the ESD protection

devices includes a source/drain terminal of the corresponding transistor.

22. (Withdrawn) The apparatus according to claim 15, wherein the

display device substrate is a TFT array substrate of a liquid crystal display.